SILICON PIN PHOTO DIODE

AT40S-PD-01

DATA SHEET

REV. : 1.0

DATE: 20-Apr.-2007

■ FEATURES:

- ■ Fast Response Time.
- ■ High Photo Sensitive.
- ■ Small Junction Capacitance.
- ■ Lead free product, in compliance with RoHS.

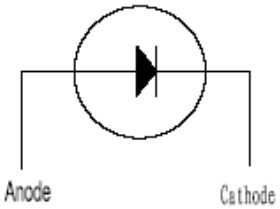
■ DESCRIPTIONS:

- ■ AT40S-PD-01 is a high response speed and high sensitive silicon PIN photo diode with exceptionally stable characteristics and high illumination sensitivity.
- ■ Molded in a compact surface-mountable package.

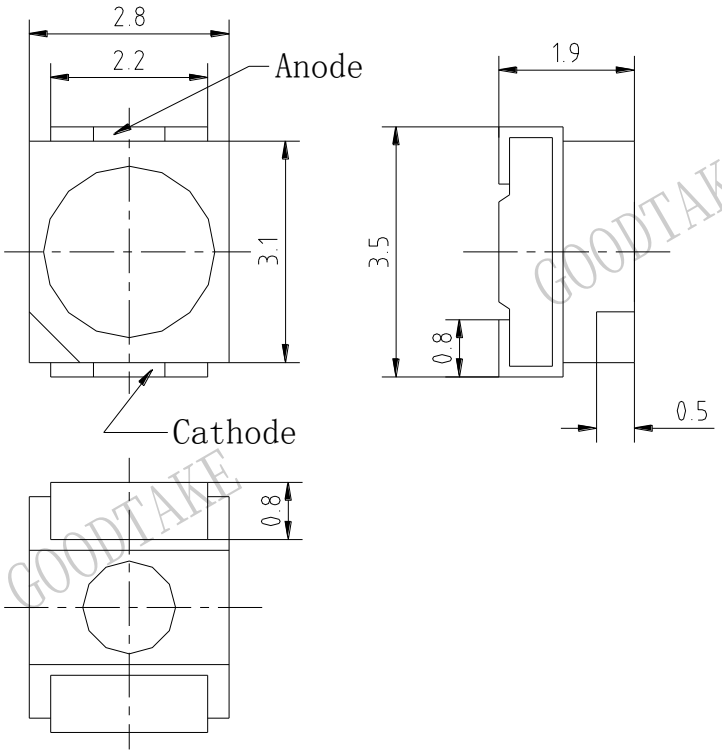
■ APPLICATIONS:

- ■ Miniature switch.
- ■ Counters and sorter.
- ■ Position sensors.
- ■ Infrared applied system.

■ INTERNAL CIRCUIT:



■ DIMENSIONS:



NOTE： All dimensions are in millimeter, tolerance is ±0.2 unless otherwise noted.

■ ABSOLUTE MAXIMUM RATINGS AT Ta=25℃

Parameter	Symbol	Ratings	Unit
Power Dissipation	P_D	150	mW
Reverse Breakdown Voltage	V_{BR}	35	V
Operating Temperature	Topr	-40～+85	℃
Storage Temperature	Tstg	-55～+100	℃
Soldering Temperature	Tsol	260℃ for 6 sec Max	

■ TYPICAL ELECTRICAL & OPTICAL CHARACTERISTICS（Ta=25℃）

Parameter	Symbol	Min.	Type	Max.	Unit	Test Condition
Reverse Breakdown Voltage	**$V_{(BR)}$**	35			V	IR=100μA Ee=0mW/cm^2
Open-Circuit Voltage	**V_{OC}**		0.4		V	λp=940 nm Ee=5mW/cm^2
Short-Circuit current	**I_{SC}**		0.8		μA	λp=875 nm Ee=1mW/cm^2
Rise Time	**Tr**		6		nS	V_R=5V R_L=1000Ω
Fall Time	T_f		6		nS	
Dark Current	**I_D**			10	nA	VR=10V Ee=0mW/cm^2
Light Current	I_L		1.6		μA	λp=875 nm VR=5V Ee=1mW/cm^2
Range Of Spectral Bandwidth	$\lambda_{1/2}$	700		1100	nm	
Peak Wavelength of Sensitive	λp		940		nm	

■ RELIABILITY TEST ITEMS AND CONDITIONS:

NO	Item	Test Conditions	Test Hours/Cycle	Sample Quantity	Test Result
1	Solder Heat	TEMP：270℃±3℃	10 SEC	11 pcs	0 DEFECT
2	Temperature Cycle	H:+85℃ 60min ↕ 10min L:-25℃ 60min	16 cycles	22 pcs	0 DEFECT
3	Thermal Shock	H:+85℃ 30min ↕ 30sec L:-25℃ 30min	10 cycles	11 pcs	0 DEFECT
4	High Temperature Storage	TEMP：+85℃	1000 HRS	22 pcs	0 DEFECT
5	Low Temperature Storage	TEMP：-25℃	1000 HRS	22 pcs	0 DEFECT
6	High Temperature High Humidity Storage	85℃/93% RH	1000HRS	22 pcs	0 DEFECT

■ TYPICAL ELECTRO-OPTICAL CHARACTERISTICS CURVES:

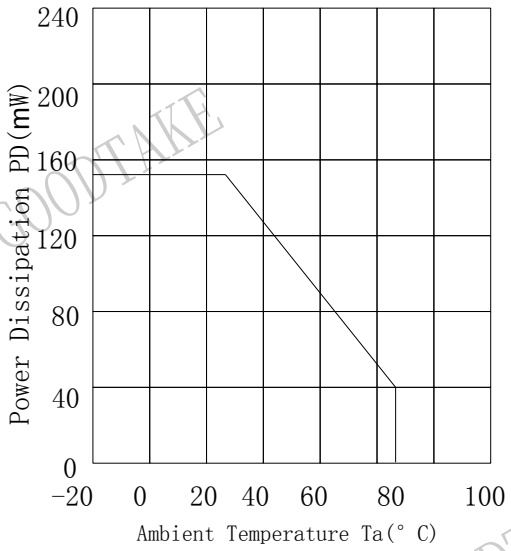


Fig.1 Power Dissipation vs Ambient Temperation

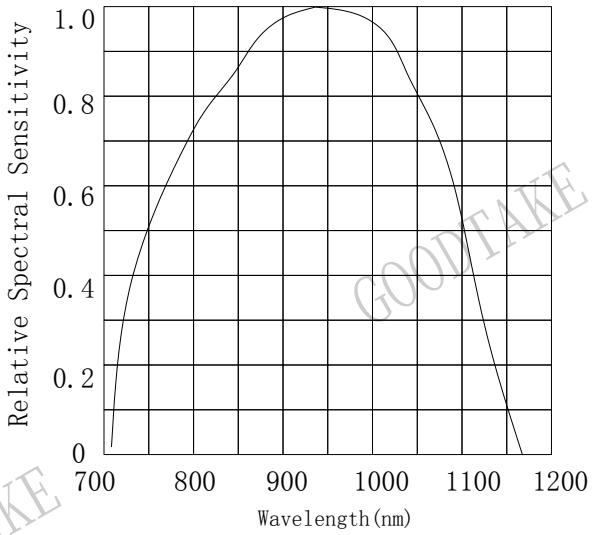


FIG.2 Spectral Sensitivity

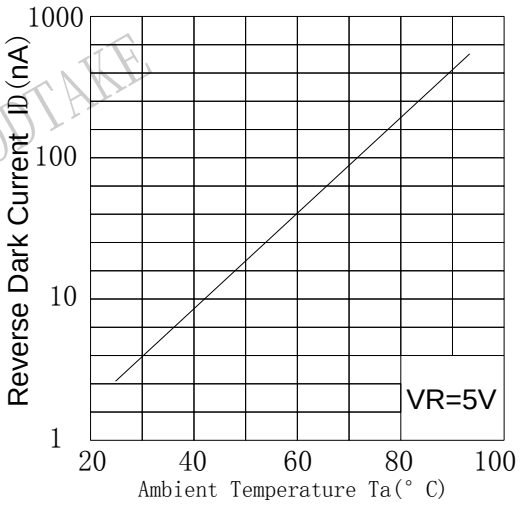


Fig.3 Dark Current vs Ambient Temperation

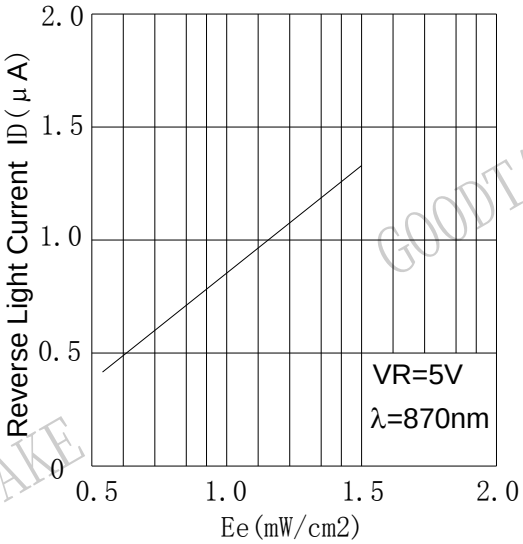


Fig.4 Reverse Light Current vs Ambient Temperation